

TPS2105-EP V_{AUX} 配电开关

1 特性

- 无反向电流（无寄生二极管）的双输入、单输出金属氧化物半导体场效应晶体管 (MOSFET) 开关
- IN1: 250mΩ, 500mA N 通道; 18μA 电源电流
- IN2: 1.3mΩ, 100mA P 通道; 0.75μA 电源电流 (V_{AUX} 模式)
- 高级开关控制逻辑
- CMOS 和 TTL 兼容使能输入
- 受控上升、下降和转换时间
- 2.7V 至 5.5V 的工作范围
- 小外形尺寸晶体管 (SOT)-23-5 封装
- 2kV 人体模型, 750V 充电器件模型, 200V 机器模型静电放电 (ESD) 保护
- 支持国防、航天和医疗应用
 - 受控基线
 - 同一组装和测试场所
 - 同一制造场所
 - 支持军用 (-55°C 至 125°C) 温度范围
 - 延长的产品生命周期
 - 延长的产品变更通知
 - 产品可追溯性

2 应用范围

- 笔记本和台式机
- 手机、掌上电脑和个人数字助理 (PDA)
- 电池管理

3 说明

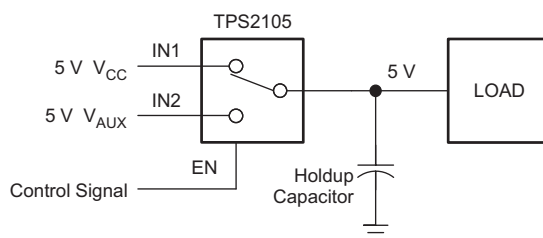
TPS2105 是一款双输入、单输出电源开关, 此开关设计用于在两个独立电源之间转换时提供不间断输出电压。两个器件都包含具有单个输出的 N 通道 (250mΩ) 和 P 通道 (1.3Ω) MOSFET。P 通道 MOSFET (IN2) 与辅助电源一同使用, 这些辅助电源为待机模式传送较低电流。N 通道 MOSFET (IN1) 与主电源一同使用, 此电源提供正常运行所需的较高电流。当电源稳压和系统压降十分关键时, 低导通电阻使得 N 通道成为较高主电源电流的理想通路。当使用 P 通道 MOSFET 时, 静态电流被减少至 0.75μA, 以减少对待机电源的需求。TPS2105 中的 MOSFET 无常见于离散 MOSFET 中的寄生二极管, 从而防止在开关关闭时的回流电流。

器件信息⁽¹⁾

订货编号	封装	封装尺寸 (标称值)
TPS2105MDBVREP	SOT-23 (5)	2.90mm x 1.60mm

(1) 要了解所有可用封装, 请见数据表末尾的可订购产品附录。

简化电路原理图



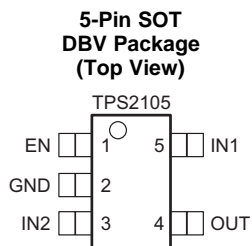
目录

1	特性	1	7.2	Functional Block Diagram	9
2	应用范围	1	7.3	Feature Description	9
3	说明	1	7.4	Device Functional Modes	10
4	修订历史记录	2	8	Application and Implementation	11
5	Pin Configuration and Functions	3	8.1	Application Information	11
6	Specifications	4	8.2	Typical Application	11
6.1	Absolute Maximum Ratings	4	9	Power Supply Recommendations	14
6.2	Handling Ratings	4	10	Layout	14
6.3	Recommended Operating Conditions	4	10.1	Layout Guidelines	14
6.4	Thermal Information	4	10.2	Layout Examples	15
6.5	Electrical Characteristics	5	11	器件和文档支持	17
6.6	Switching Characteristics	6	11.1	Trademarks	17
6.7	Typical Characteristics	7	11.2	Electrostatic Discharge Caution	17
7	Detailed Description	9	11.3	术语表	17
7.1	Overview	9	12	机械封装和可订购信息	17

4 修订历史记录

日期	版本	注释
2014 年 7 月	*	最初发布版本

5 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
EN	1	I	Active-high enable for IN1-OUT switch
GND	2	I	Ground
IN1 ⁽¹⁾	5	I	Main input voltage, NMOS drain (250 mΩ), requires 0.22-μF bypass
IN2 ⁽¹⁾	3	I	Auxiliary input voltage, PMOS drain (1.3 Ω), requires 0.22-μF bypass
OUT	4	O	Power switch output

(1) Unused INx should not be grounded.

Table 1. Function Table

TPS2105			
VIN1	VIN2	EN	OUT
0 V	0 V	XX ⁽¹⁾	GND
0 V	5 V	h	GND
5 V	0 V	h	VIN1
5 V	5 V	h	VIN1
0 V	5 V	l	VIN2
5 V	0 V	l	VIN2
5 V	5 V	l	VIN2

(1) XX = Don't care

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
$V_{I(IN1)}$	Input voltage ⁽²⁾	-0.3	6	V
$V_{I(IN2)}$	Input voltage ⁽²⁾	-0.3	6	V
	Input voltage, V_I at EN ⁽²⁾	-0.3	6	V
V_O	Output voltage ⁽²⁾	-0.3	6	V
$I_{O(IN1)}$	Continuous output current		700	mA
$I_{O(IN2)}$	Continuous output current		140	mA
	Continuous total power dissipation	See Thermal Information		
T_J	Operating virtual junction temperature	-55	150	°C
	Lead temperature soldering 1.6 mm (1/16 inch) from case for 10 s		260	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to GND.

6.2 Handling Ratings

		MIN	MAX	UNIT	
T_{stg}	Storage temperature range	-65	150	°C	
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	-2000	2000	V
		Machine model (MM) ESD stress voltage	-200	200	
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	-750	750	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
$V_{I(INx)}$	Input voltage	2.7	5.5	V
	Input voltage, V_I at EN	0	5.5	V
$I_{O(IN1)}$	Continuous output current		500	mA
$I_{O(IN2)}$	Continuous output current		100 ⁽¹⁾	mA
T_J	Operating virtual junction temperature	-55	125	°C

- (1) The device can deliver up to 220 mA at $I_{O(IN2)}$. However, operation at the higher current levels results in greater voltage drop across the device, and greater voltage droop when switching between IN1 and IN2.

6.4 Thermal Information

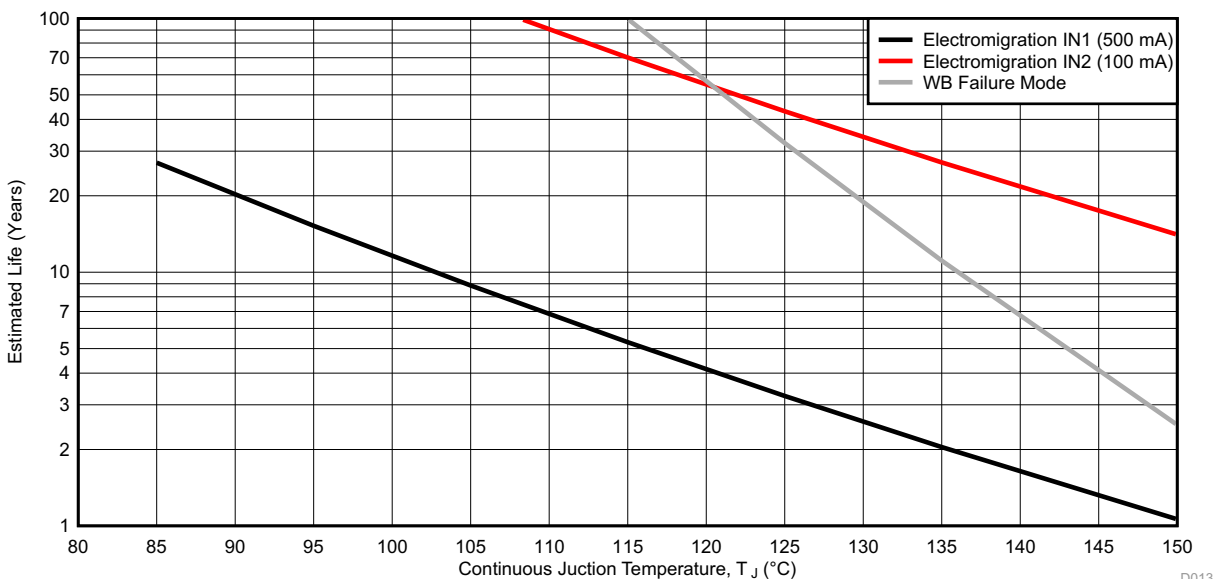
THERMAL METRIC ⁽¹⁾		TPS2105-EP	UNIT
		DBV (5 PINS)	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	208.7	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	122.9	
$R_{\theta JB}$	Junction-to-board thermal resistance	36.7	
Ψ_{JT}	Junction-to-top characterization parameter	14.2	
Ψ_{JB}	Junction-to-board characterization parameter	35.8	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	

- (1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, [SPRA953](#).

6.5 Electrical Characteristics

Over recommended operating range (unless otherwise specified)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER SWITCH					
$r_{DS(on)}$ On-state resistance	IN1-OUT, $V_{I(IN1)} = 5.5\text{ V}$, $V_{I(IN2)} = 0\text{ V}$		250	435	m Ω
	IN2-OUT, $V_{I(IN2)} = 5.5\text{ V}$, $V_{I(IN1)} = 0\text{ V}$		1.3	2.4	Ω
ENABLE INPUT					
V_{IH} High-level input voltage	$2.7\text{ V} \leq V_{I(INx)} \leq 5.5\text{ V}$	2			V
V_{IL} Low-level input voltage	$2.7\text{ V} \leq V_{I(INx)} \leq 5.5\text{ V}$			0.8	V
I_I Input current	EN = 0 V or EN = $V_{I(INx)}$	-0.65		0.65	μA
SUPPLY CURRENT					
I_I Supply current	EN = L, IN2 selected		0.75	1.5	μA
	EN = H, IN1 selected		18	35	μA



- (1) Wirebond life = Time at temperature with or without bias
- (2) Electromigration fail mode = Time at temperature with bias
- (3) Silicon operating life design goal is 10 years at 105°C junction temperature (does not include package interconnect life).
- (4) The predicted operating lifetime versus junction temperature is based on reliability modeling and available qualification data.

Figure 1. Predicted Lifetime Derating Chart for TPS2105-EP

6.6 Switching Characteristics

$T_J = 25^\circ\text{C}$, $V_{I(IN1)} = V_{I(IN2)} = 5\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_r	Output rise time	IN1-OUT	$V_{I(IN2)} = 0$	$C_L = 1\ \mu\text{F}, I_L = 500\ \text{mA}$	340		μs
				$C_L = 10\ \mu\text{F}, I_L = 500\ \text{mA}$	340		
				$C_L = 1\ \mu\text{F}, I_L = 100\ \text{mA}$	312		
		IN2-OUT	$V_{I(IN1)} = 0$	$C_L = 1\ \mu\text{F}, I_L = 100\ \text{mA}$	3.4		
				$C_L = 10\ \mu\text{F}, I_L = 100\ \text{mA}$	34		
				$C_L = 1\ \mu\text{F}, I_L = 10\ \text{mA}$	3.5		
t_f	Output fall time	IN1-OUT	$V_{I(IN2)} = 0$	$C_L = 1\ \mu\text{F}, I_L = 500\ \text{mA}$	6		μs
				$C_L = 10\ \mu\text{F}, I_L = 500\ \text{mA}$	108		
				$C_L = 1\ \mu\text{F}, I_L = 100\ \text{mA}$	8		
		IN2-OUT	$V_{I(IN1)} = 0$	$C_L = 1\ \mu\text{F}, I_L = 100\ \text{mA}$	100		
				$C_L = 10\ \mu\text{F}, I_L = 100\ \text{mA}$	990		
				$C_L = 1\ \mu\text{F}, I_L = 10\ \text{mA}$	1000		
t_{PLH}	Propagation delay time, low-to-high output	IN1-OUT	$V_{I(IN2)} = 0$	55		μs	
		IN2-OUT	$V_{I(IN1)} = 0$	1			
t_{PHL}	Propagation delay time, high-to-low output	IN1-OUT	$V_{I(IN2)} = 0$	1.5		μs	
		IN2-OUT	$V_{I(IN1)} = 0$	50			

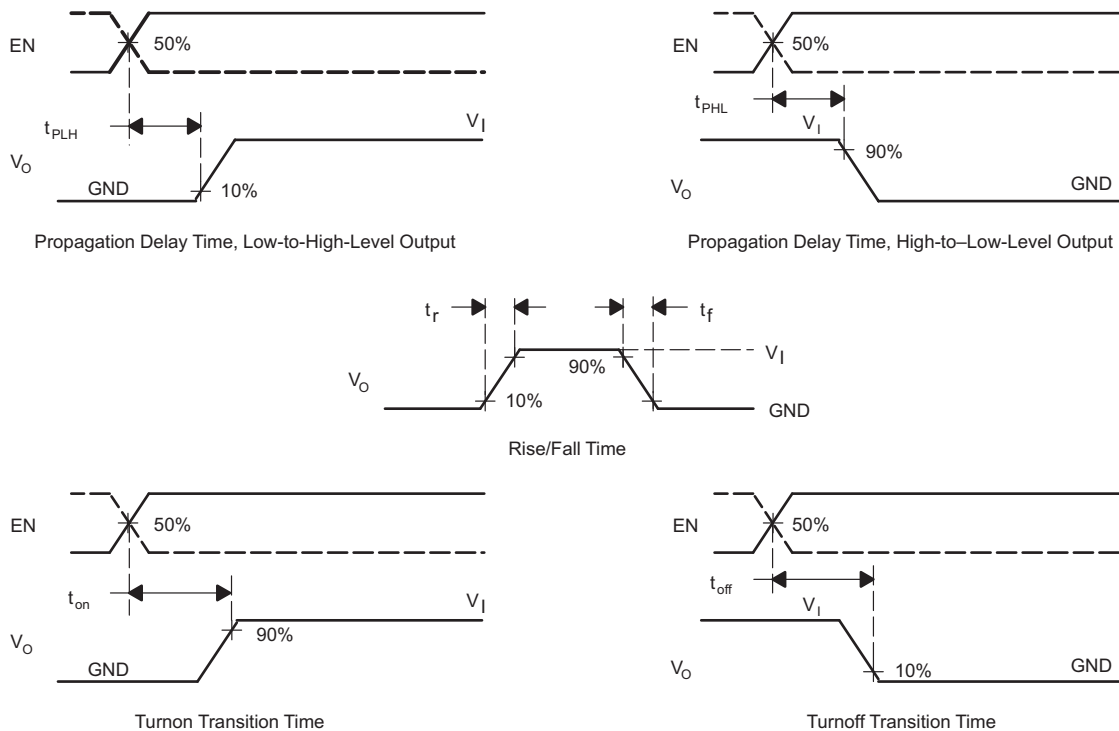
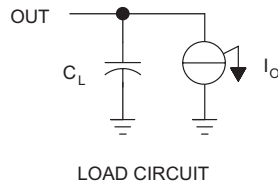


Figure 2. Test Circuit and Voltage Waveforms

6.7 Typical Characteristics

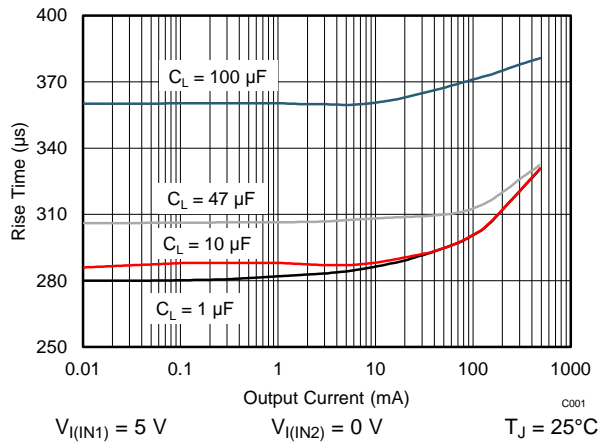


Figure 3. IN1 Switch Rise Time vs Output Current

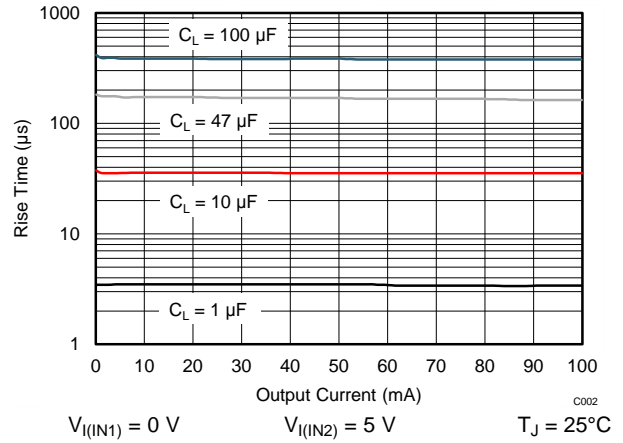


Figure 4. IN2 Switch Rise Time vs Output Current

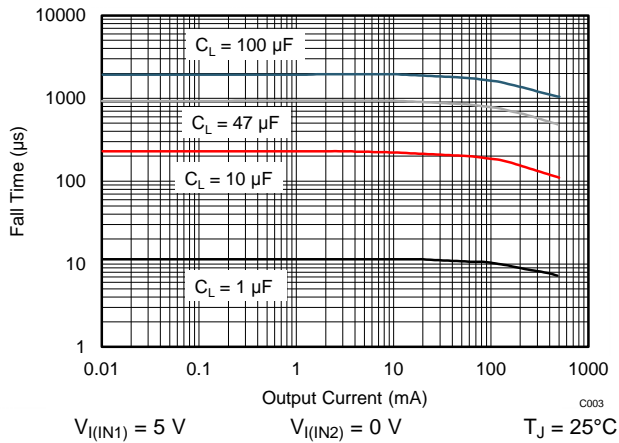


Figure 5. IN1 Switch Fall Time vs Output Current

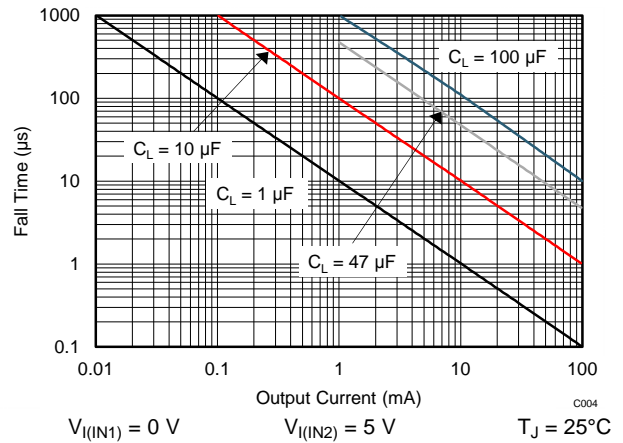
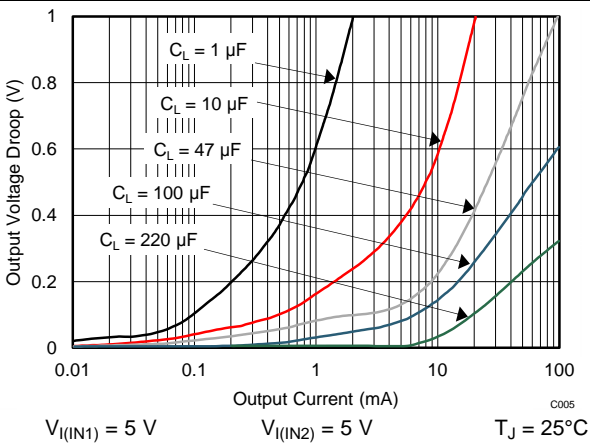


Figure 6. IN2 Switch Fall Time vs Output Current



If switching from IN1 to IN2, the voltage droop is much smaller. Thus, choose the load capacitance according to [Figure 6](#).

Figure 7. Output Voltage Droop vs Output Current When Output is Switched from IN2 to IN1

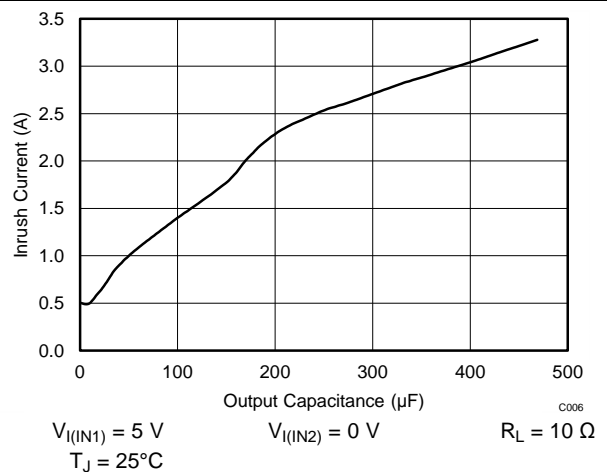


Figure 8. Inrush Current vs Output Capacitance

Typical Characteristics (continued)

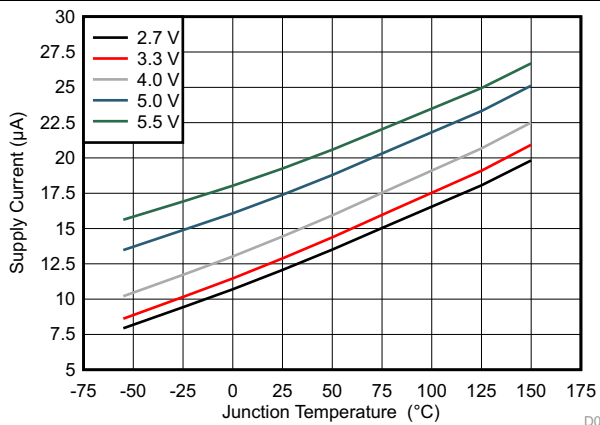


Figure 9. IN1 Supply Current vs Junction Temperature (IN1 Enabled)

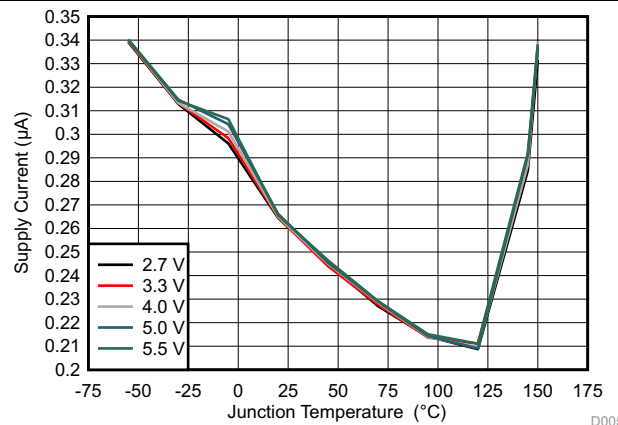


Figure 10. IN1 Supply Current vs Junction Temperature (IN1 Disabled)

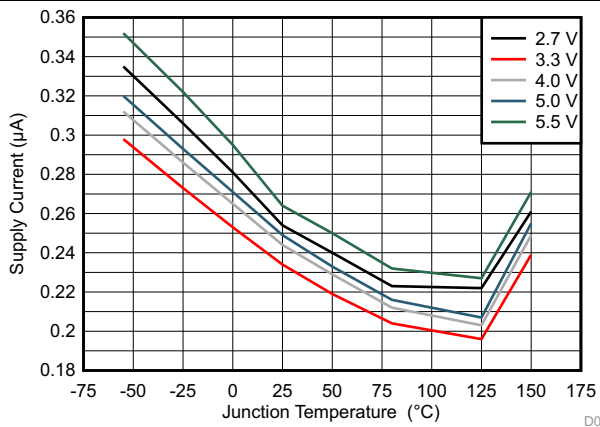


Figure 11. IN2 Supply Current vs Junction Temperature (IN2 Enabled)

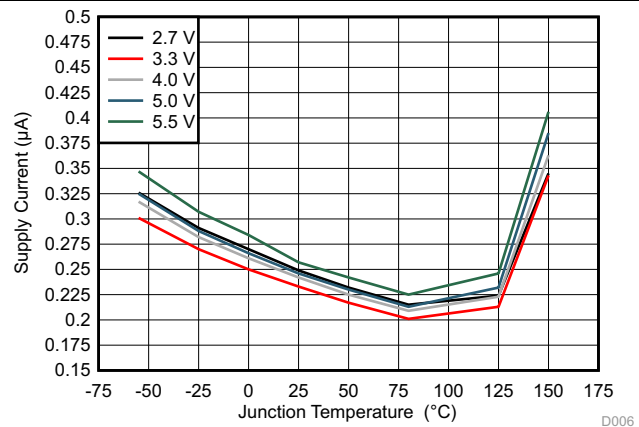


Figure 12. IN2 Supply Current vs Junction Temperature (IN2 Disabled)

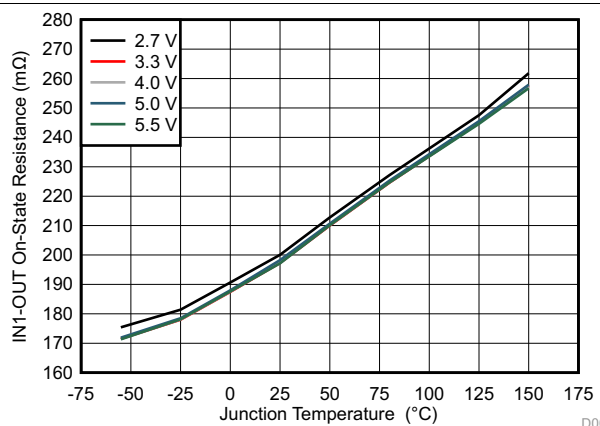


Figure 13. IN1-Out On-State Resistance vs Junction Temperature

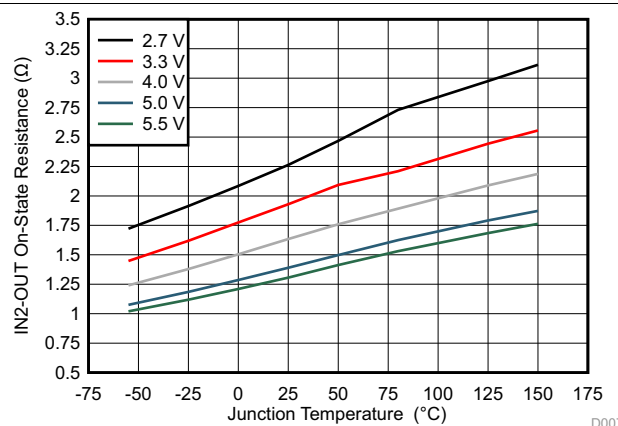


Figure 14. IN2-Out On-State Resistance vs Junction Temperature

7 Detailed Description

7.1 Overview

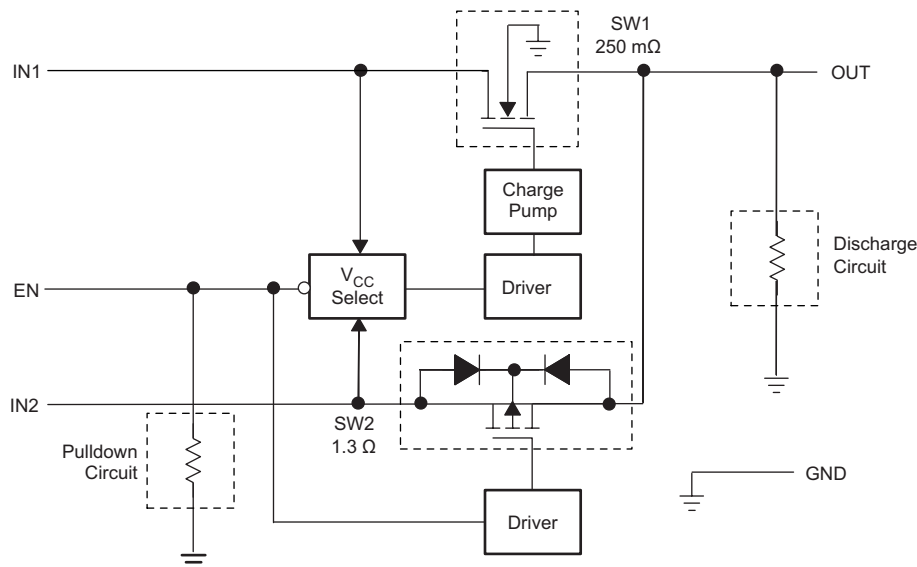
The TPS2105 is a dual-input, single-output power switch designed to provide uninterrupted output voltage when transitioning between two independent power supplies.

The device combines one N-channel (250-m) MOSFET with a single output. The P-channel MOSFET (IN2) is used with auxiliary power supplies that deliver lower current for standby modes. The N-channel MOSFET (IN1) is used with a main power supply that delivers higher current required for normal operation.

The low on-resistance makes the N-channel the ideal path for higher main supply current when power-supply regulation and system voltage drops are critical. When using the P-channel MOSFET, quiescent current is reduced to 0.75 μA to decrease the demand on the standby power supply.

The MOSFETs in the device do not have the parasitic diodes, typically found in discrete MOSFETs, thereby preventing back-flow current when the switch is off.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Power Switches

7.3.1.1 N-Channel MOSFET

The IN1-OUT N-channel MOSFET power switch has a typical on-resistance of 250 m Ω at 5-V input voltage and is configured as a high-side switch.

7.3.1.2 P-Channel MOSFET

The IN2-OUT P-channel MOSFET power switch has a typical on-resistance of 1.3 Ω at 5-V input voltage and is configured as a high-side switch. When operating, the P-channel MOSFET quiescent current is reduced to typically 0.75 μA .

7.3.1.3 Charge Pump

An internal charge pump supplies power to the driver circuit and provides the necessary voltage to pull the gate of the MOSFET above the source. The charge pump operates from input voltages as low as 2.7 V and requires very little supply current.

Feature Description (continued)

7.3.1.4 Driver

The driver controls the gate voltage of the IN1-OUT and IN2-OUT power switches. To limit large current surges and reduce the associated electromagnetic interference (EMI) produced, the drivers incorporate circuitry that controls the rise times and fall times of the output voltage.

7.3.1.5 Enable

The logic enable turns on the IN2-OUT power switch when a logic low is present on EN. A logic high on EN restores bias to the drive and control circuits and turns on the IN1-OUT power switch. The enable input is compatible with both TTL and CMOS logic levels.

7.4 Device Functional Modes

7.4.1 Operation With EN Control

The logic enable turns on the IN1-OUT power switch when a logic high is present on EN. Also, a logic low present on EN turns off the IN1-OUT and turns on the IN2-OUT power switch.

8 Application and Implementation

8.1 Application Information

The TPS2105 is a dual-input, single-output power switch designed to provide uninterrupted output voltage when transitioning between two independent power supplies.

8.2 Typical Application

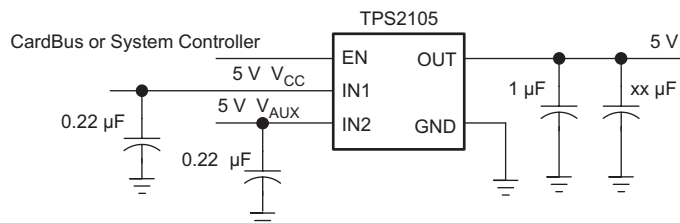


Figure 15. Typical Application Schematic

8.2.1 Design Requirements

For this design example, use the following as the input parameters.

Table 2. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Input voltage range, $V_{I(IN1)}$	5 V
Input voltage range, $V_{I(IN2)}$	5 V
Output voltage	5 V
Continuous output current, I_O	100 mA
Output capacitor, C_L	220 μ F

8.2.2 Detailed Design Procedure

8.2.2.1 Step-by-Step Design Procedure

To begin the design process, the designer must decide upon a few parameters. The designer needs to know the following:

- Input voltage range, $V_{I(IN1)}$
- Input voltage range, $V_{I(IN2)}$
- Output voltage
- Continuous output current
- Output capacitance

8.2.2.2 Power-Supply Considerations

TI recommends a 0.22- μ F ceramic bypass capacitor between IN and GND, close to the device. The output capacitor should be chosen based on the size of the load during the transition of the switch. TI recommends a 220- μ F capacitor for 100-mA loads. Typical output capacitors (xx μ F, shown in Figure 15) required for a given load can be determined from Figure 7, which shows the output voltage droop when output is switched from IN2 to IN1. The output voltage droop is insignificant when output is switched from IN1 to IN2. Additionally, bypassing the output with a 1- μ F ceramic capacitor improves the immunity of the device to short-circuit transients.

8.2.2.3 Switch Transition

The N-channel MOSFET on IN1 uses a charge pump to create the gate-drive voltage, which gives the IN1 switch a rise time of approximately 0.4 ms. The P-channel MOSFET on IN2 has a simpler drive circuit that allows a rise time of approximately 4 μ s. Because the device has two switches and a single enable pin, these rise times are seen as transition times, from IN1 to IN2, or IN2 to IN1, by the output. The controlled transition times help limit the surge currents seen by the power supply during switching.

8.2.2.4 Thermal Protection

Thermal protection provided on the IN1 switch prevents damage to the IC when heavy-overload or short-circuit faults are present for extended periods of time. The increased dissipation causes the junction temperature to rise to dangerously high levels. The protection circuit senses the junction temperature of the switch and shuts it off at approximately 145°C (T_J). The switch remains off until the junction temperature has dropped approximately 10°C. The switch continues to cycle in this manner until the load fault or input power is removed.

8.2.2.5 Undervoltage Lockout

An undervoltage lockout function is provided to ensure that the power switch is in the off state at power-up. Whenever the input voltage falls below approximately 2 V, the power switch quickly turns off. This function facilitates the design of hot-insertion systems that may not have the capability to turn off the power switch before input power is removed. Upon reinsertion, the power switch is turned on with a controlled rise time to reduce EMI and voltage overshoots.

8.2.2.6 Power Dissipation and Junction Temperature

The low on-resistance on the N-channel MOSFET allows small surface-mount packages, such as SOIC, to pass large currents. The thermal resistances of these packages are high compared to those of power packages; it is a good design practice to check power dissipation and junction temperature. First, find r_{on} at the input voltage and operating temperature. As an initial estimate, use the highest operating ambient temperature of interest and read r_{on} from [Figure 13](#) or [Figure 14](#). Next calculate the power dissipation using:

$$P_D = r_{on} \times I^2 \quad (1)$$

Finally, calculate the junction temperature:

$$T_J = P_D \times R_{\theta JA} + T_A$$

where

- T_A = Ambient temperature
- R_{θJA} = Thermal resistance (2)

Compare the calculated junction temperature with the initial estimate. If they do not agree within a few degrees, repeat the calculation using the calculated value as the new estimate. Two or three iterations are generally sufficient to obtain a reasonable answer.

8.2.2.7 ESD Protection

All TPS2105 pins incorporate ESD-protection circuitry designed to withstand a 2-kV human-body-model, 750-V CDM, and 200-V machine-model discharge as defined in MIL-STD-883C.

8.2.3 Application Curves

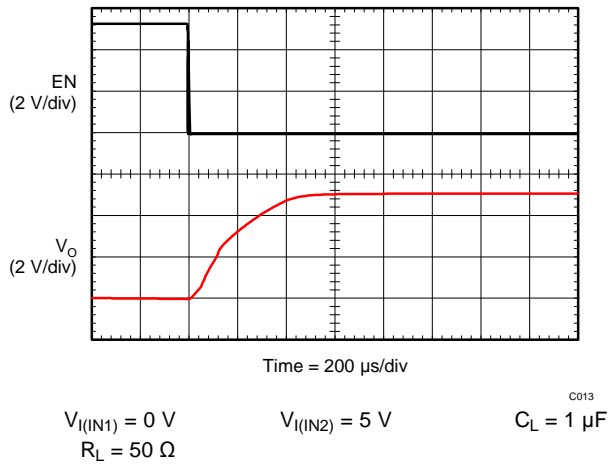


Figure 16. Propagation Delay and Rise Time With 1-µF Load, IN2 Turnon

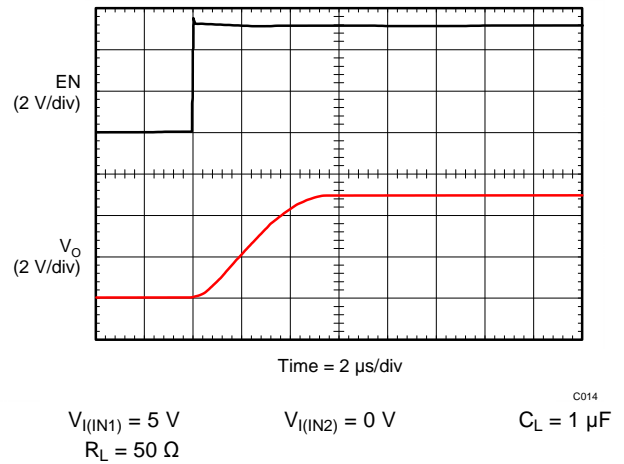


Figure 17. Propagation Delay and Rise Time With 1-µF Load, IN1 Turnon

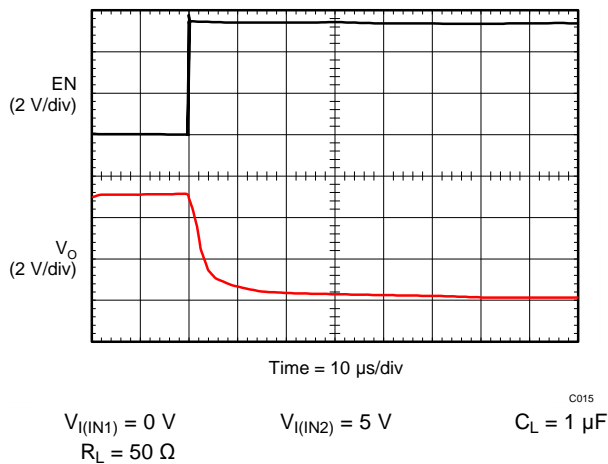


Figure 18. Propagation Delay and Fall Time With 1-µF Load, IN2 Turnoff

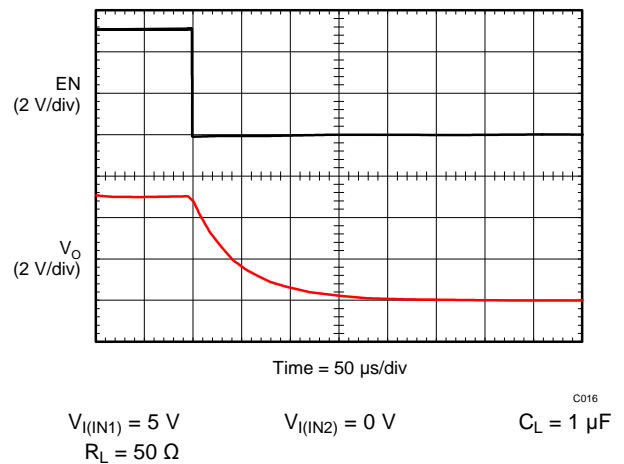


Figure 19. Propagation Delay and Fall Time With 1-µF Load, IN1 Turnoff

9 Power Supply Recommendations

The device is designed to operate from an input voltage supply range from 2.7 to 5.5 V. A 0.22- μ F ceramic bypass capacitor is needed between IN and GND; TI recommends placing the capacitor close to the device. The output capacitor should be chosen based on the size of the load during the transition of the switch. TI recommends a 220- μ F capacitor for 100-mA loads. Adding a 1- μ F ceramic bypass capacitor at the output can help to improve the immunity of the device to short-circuit transients.

TPS2105-EP requires a high-quality ceramic, type X5R or X7R, input decoupling capacitor. The value of a ceramic capacitor varies significantly over temperature and the amount of DC bias applied to the capacitor. The capacitance variations due to temperature can be minimized by selecting a dielectric material that is stable over temperature. X5R and X7R ceramic dielectrics are usually selected for power regulator capacitors because they have a high capacitance to volume ratio and are fairly stable over temperature. The output capacitor must also be selected with the DC bias taken into account. Ceramic capacitors lose capacitance when a DC bias is applied across the capacitor. This capacitance loss is due to the polarization of the ceramic material. The capacitance loss is not permanent; after a large DC bias is applied, reducing the DC bias reduces the degree of polarization and capacitance increases. The capacitance value of a capacitor decreases as the DC bias across a capacitor increases.

All tantalum capacitors have tantalum (Ta) particles sintered together to form an anode. The cathode material can either be the traditional MnO_2 or a conductive polymer. Because MnO_2 is actually a semiconductor, it has a very high amount of resistance associated with it. A characteristic of this material is that as temperature changes, so does its conductivity. So MnO_2 -based Tantalum capacitors have relatively high ESR and that ESR shifts significantly across the operational temperature range.

However, polymer-based cathodes use a highly-conductive polymer material. Because the material is inherently conductive, tantalum-polymers have a relatively-low ESR compared to their MnO_2 counterparts in the same voltage and capacitance ranges.

All tantalum capacitors have a voltage derating factor associated with them. Because the polymer material puts less stress on the tantalum-pentoxide dielectric during reflow soldering, more voltage can be applied compared to a MnO_2 -based tantalum. For polymer-based capacitors, TI recommends 20% derating. Whereas the MnO_2 -based tantalum capacitors require 50% or higher derating. Refer to the capacitor vendor data sheet for more details regarding the derating guidelines.

10 Layout

10.1 Layout Guidelines

- The IN1 and OUT pins of the TPS2105-EP can carry up to 500 mA, so trace to these pins should have short length and wider traces to minimize the voltage drop to the load.
- Both the IN1 and IN2 pins should be bypassed to ground with a low-ESR ceramic bypass capacitor. The typical recommended bypass capacitance is 0.22- μ F ceramic capacitor.
- A bypass capacitor and a load capacitor are needed on the output terminal.
- TI recommends a 220- μ F output load capacitor for 100-mA loads.
- Locating the 1- μ F ceramic bypass capacitor at the output can improve the immunity of the device to short-circuit transients.
- The GND terminal should be tied to the PCB ground plane at the terminal of the DUT.

10.2 Layout Examples

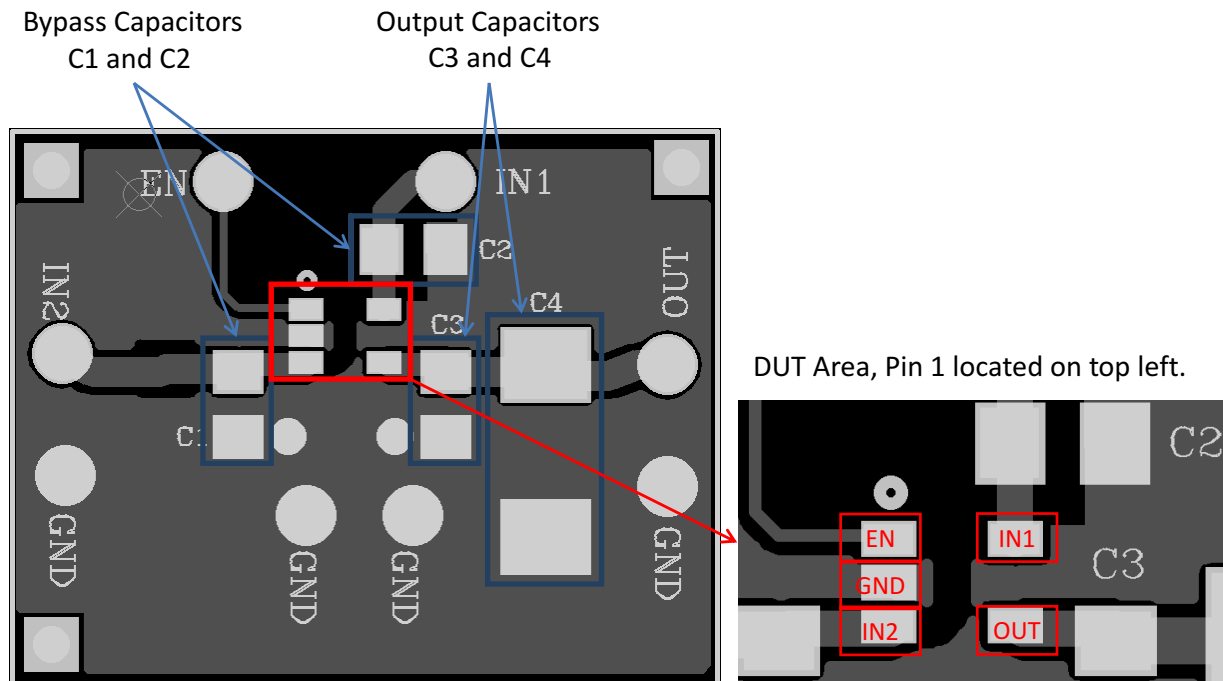


Figure 20. Input and Output Capacitors and DUT Area

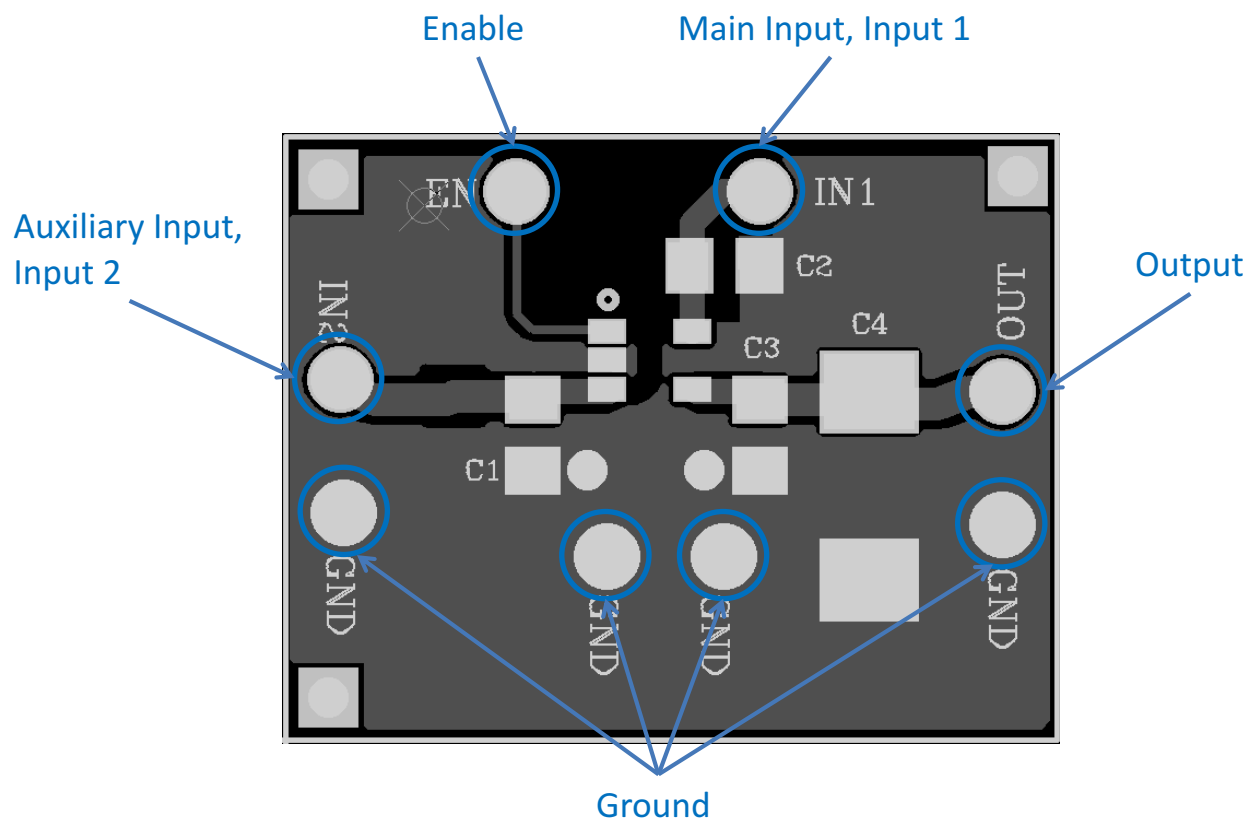
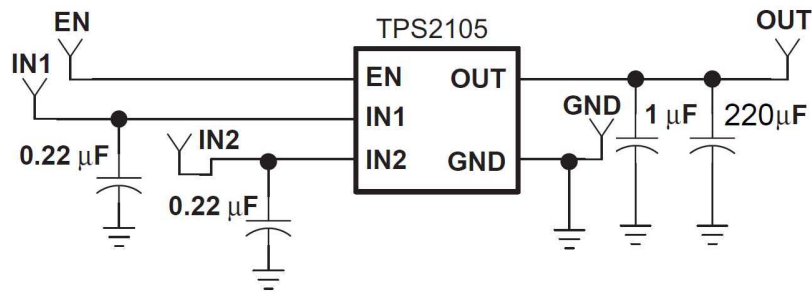


Figure 21. Enable, Input, Output, and Ground Pins

Layout Examples (continued)

Figure 22. Schematics Diagram
Table 3. Component Descriptions

PART	DESCRIPTION
C ₁ , C ₂	0.22 μF, size 0805
C ₃	1 μF, size 0805
C ₄	220 μF, tantalum capacitors
U ₁	TPS2105MDBVREP
TP_EN, TP_IN ₁ , TP_IN ₂ , TP_OUT, TP_GND	Test point, through hole

11 器件和文档支持

11.1 Trademarks

All trademarks are the property of their respective owners.

11.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.3 术语表

[SLYZ022](#) — *TI* 术语表。

这份术语表列出并解释术语、首字母缩略词和定义。

12 机械封装和可订购信息

以下页中包括机械封装和可订购信息。 这些信息是针对指定器件可提供的最新数据。 这些数据会在无通知且不对本文档进行修订的情况下发生改变。 欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS2105MDBVREP	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	PD9M	Samples
V62/14616-01XE	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	PD9M	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

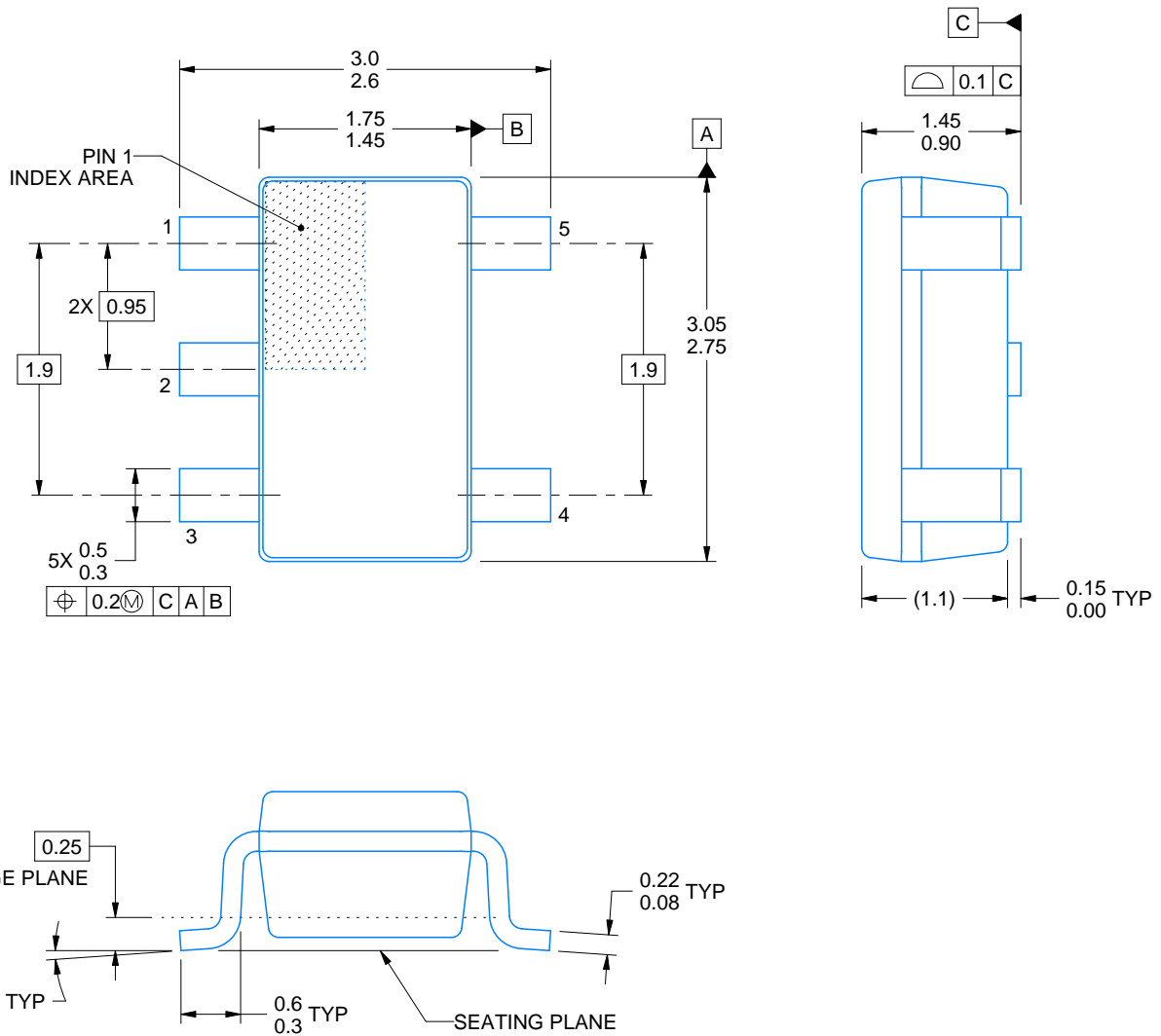


DBV0005A

PACKAGE OUTLINE

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



4214839/F 06/2021

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC MO-178.
4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.

EXAMPLE BOARD LAYOUT

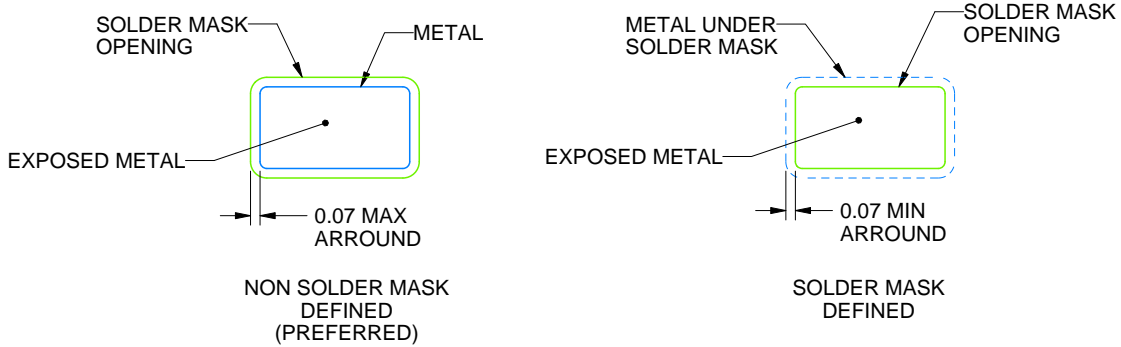
DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

4214839/F 06/2021

NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4214839/F 06/2021

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

重要声明和免责声明

TI“按原样”提供技术和可靠性数据（包括数据表）、设计资源（包括参考设计）、应用或其他设计建议、网络工具、安全信息和其他资源，不保证没有瑕疵且不做任何明示或暗示的担保，包括但不限于对适销性、某特定用途方面的适用性或不侵犯任何第三方知识产权的暗示担保。

这些资源可供使用 TI 产品进行设计的熟练开发人员使用。您将自行承担以下全部责任：(1) 针对您的应用选择合适的 TI 产品，(2) 设计、验证并测试您的应用，(3) 确保您的应用满足相应标准以及任何其他功能安全、信息安全、监管或其他要求。

这些资源如有变更，恕不另行通知。TI 授权您仅可将这些资源用于研发本资源所述的 TI 产品的应用。严禁对这些资源进行其他复制或展示。您无权使用任何其他 TI 知识产权或任何第三方知识产权。您应全额赔偿因在这些资源的使用中对 TI 及其代表造成的任何索赔、损害、成本、损失和债务，TI 对此概不负责。

TI 提供的产品受 [TI 的销售条款](#) 或 [ti.com](#) 上其他适用条款/TI 产品随附的其他适用条款的约束。TI 提供这些资源并不会扩展或以其他方式更改 TI 针对 TI 产品发布的适用的担保或担保免责声明。

TI 反对并拒绝您可能提出的任何其他或不同的条款。

邮寄地址：Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
Copyright © 2021，德州仪器 (TI) 公司